

## Notic of References Cit d

Application/Control No.

10/008,210

Applicant(s)/Patent Under Reexamination IWASAKI, MASAAKI

Examiner

Hien D. Vu

Applicant(s)/Patent Under Reexamination IWASAKI

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,533,901	07-1996	Hunt et al.	439/79
	В	US-6,190,183 B1	02-2001	Yang et al.	439/79
	С	US-5,540,598 /	07-1996	Davis, Wayne S.	439/79
	D	US-5,115,375	05-1992	Garay, Antonio A.	361/760
	Е	US-5,709,556	01-1998	Tan et al.	439/79
	F	US-4,722,691 /	02-1988	Gladd et al.	439/79
	G	US-5,382,168	01-1995	Azuma et al.	439/65
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					,
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT DOGGINERTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
į	U					
	v					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.